

Notice of References Cited	Application/Control No. 10/735,208	Applicant(s)/Patent Under Reexamination POLLACK ET AL.	
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	C	US-5,914,852	06-1999	Hatanaka et al.	361/523
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	V	✓ Sankaran et al, Macromolecules, 30, pp 2582-2588, 1997
	W	✓ de Leeuw et al, Technical Digest, International Electron Devices Meeting, pp 293-296, 2002
	X	✓ Touwslager et al, Synthetic Metals, 135-136, pp 53-54, 2003

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.